

# **Si6410DQ**

## 30V N-Channel PowerTrench® MOSFET

### **General Description**

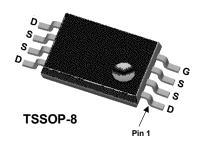
This N-Channel MOSFET is a rugged gate version of Fairchild Semiconductor's advanced PowerTrench process. It has been optimized for power management applications requiring a wide range of gate drive voltage ratings (4.5V to 20V).

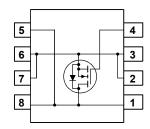
### **Applications**

- · Battery protection
- DC/DC conversion
- Power management
- Load switch

### **Features**

- 7.8 A, 30 V  $R_{DS(ON)}$  = 14 m $\Omega$  @ V<sub>GS</sub> = 10 V  $R_{DS(ON)}$  = 21 m $\Omega$  @ V<sub>GS</sub> = 4.5 V
- $\bullet~$  Extended  $V_{\text{GSS}}$  range (±20V) for battery applications
- High performance trench technology for extremely low  $R_{\mbox{\scriptsize DS}(\mbox{\scriptsize ON})}$
- Low profile TSSOP-8 package





### Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		30	V
V <sub>GSS</sub>	Gate-Source Voltage		± 20	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1)	7.8	Α
	<ul><li>Pulsed</li></ul>		20	
P <sub>D</sub>	Power Dissipation	(Note 1a)	1.4	W
		(Note 1b)	1.1	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C

## **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	87	°C/W
		(Note 1b)	114	

**Package Marking and Ordering Information** 

Device Marking	Device	Reel Size	Tape width	Quantity
6410	Si6410DQ	13"	16mm	3000 units

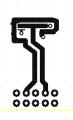
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics		1	I		1
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C		22		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V			1	μΑ
		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55^{\circ}\text{C}$			25	
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	$V_{GS} = -20 \text{ V},  V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_{D} = 250 \mu A$	1	1.6	3	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C		<b>-</b> 5		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V}, \qquad I_D = 7.8 \text{ A} $ $V_{GS} = 4.5 \text{ V}, \qquad I_D = 6.3 \text{ A}$		11 14	14 21	mΩ
I <sub>D(on)</sub>	On-State Drain Current	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 5 V	20			Α
<b>g</b> FS	Forward Transconductance	$V_{DS} = 15 \text{ V}, \qquad I_{D} = 7.8 \text{ A}$		31		S
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 \text{ V},  V_{GS} = 0 \text{ V},$		1586		pF
Coss	Output Capacitance	f = 1.0 MHz		330		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	7		120		pF
Switchin	ng Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 1 A,		9	18	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$		8	16	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	7		30	48	ns
t <sub>f</sub>	Turn–Off Fall Time	1		11	20	ns
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_F = 1.5 \text{ A},$ $dI_F/dt = 100\text{A}/\mu\text{s}$		24	80	ns
Qg	Total Gate Charge	$V_{DS} = 15 \text{ V}, I_D = 7.8 \text{ A}, V_{GS} = 5 \text{ V}$		14	20	nC
Qg	Total Gate Charge	$V_{DS} = 15 \text{ V}, \qquad I_{D} = 7.8 \text{ A},$		28	39	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V		4		nC
$Q_{gd}$	Gate-Drain Charge			5		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source				1.5	Α
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.5 A (Note 2)		0.7	1.1	V

#### Notes

1.  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a) 87°C/W when mounted on a 1in² pad of 2 oz copper.



- b) 114°C/W when mounted on a minimum pad of 2 oz copper.
  - ) Scale 1 : 1 on letter size paper

## **Typical Characteristics**

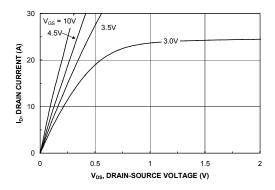


Figure 1. On-Region Characteristics.

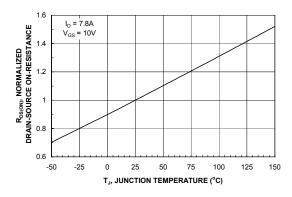


Figure 3. On-Resistance Variation with Temperature.

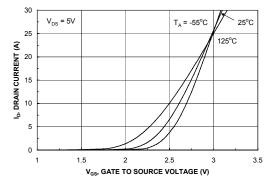


Figure 5. Transfer Characteristics.

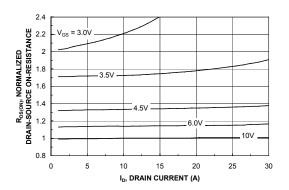


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

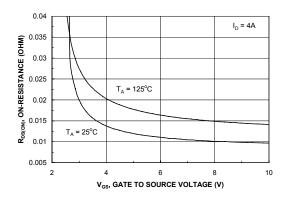


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

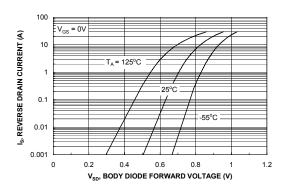
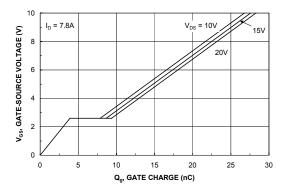


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## **Typical Characteristics**



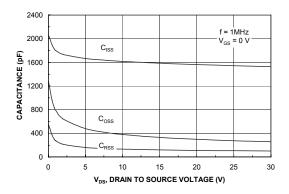
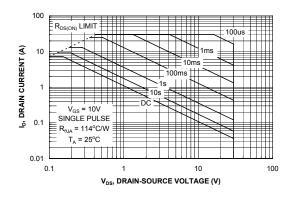


Figure 7. Gate Charge Characteristics.





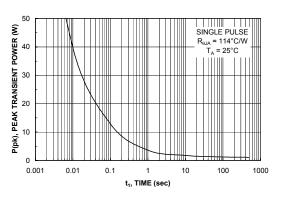


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

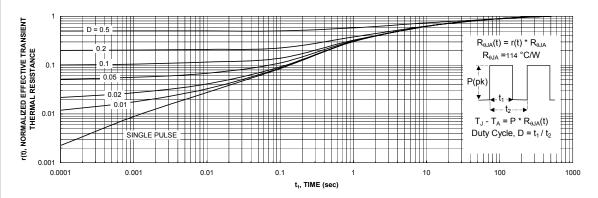


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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